


Issue Classification 	Applicati n/C ntrol No.	Applicant(s)/Patent und r Re xamination	
	10/658,576	MEI ET AL.	
	Examin r	Art Unit	
	Tae H. Yoon	1714	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS-REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
523		212		523	213				
INTERNATIONAL CLASSIFICATION?				524	431	837			
C	O	P	K	9106					
C	O	P	K	3122					
				1					
				1					
				1					
				TAE H. YOON PRIMARY EXAMINER				Total Claims Allowed: 27	
(Assistant Examiner) (Date)				Tae H. Yoon 1-10-05 (Primary Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 1
y. miller 1/11/05 (Legal Instruments Examiner) (Date)									

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original		
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